## Features

- Buffered Inputs
- Typical Propagation Delay: 7ns at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$, $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$
- Fanout (Over Temperature Range)
- Standard Outputs . . . . . . . . . . . . . . . 10 LSTTL Loads
- Bus Driver Outputs . . . . . . . . . . . . . 15 LSTTL Loads
- Wide Operating Temperature Range ... $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
- 2V to 6V Operation
- High Noise Immunity: $N_{I L}=30 \%, N_{I H}=30 \%$ of $V_{C C}$ at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$
- HCT Types
- 4.5V to 5.5V Operation
- Direct LSTTL Input Logic Compatibility, $\mathrm{V}_{\mathrm{IL}}=0.8 \mathrm{~V}$ (Max), $\mathrm{V}_{\mathrm{IH}}=2 \mathrm{~V}$ (Min)
- CMOS Input Compatibility, $\mathrm{I}_{\mathrm{I}} \leq 1 \mu \mathrm{~A}$ at $\mathrm{V}_{\mathrm{OL}}, \mathrm{V}_{\mathrm{OH}}$


## Description

The 'HCO2 and 'HCT02 logic gates utilize silicon-gate CMOS technology to achieve operating speeds similar to LSTTL gates with the low power consumption of standard CMOS integrated circuits. All devices have the ability to drive 10 LSTTL loads. The HCT logic family is functionally pin compatible with the standard LS logic family.

## Ordering Information

| PART NUMBER | TEMP. RANGE $\left({ }^{\circ} \mathrm{C}\right)$ | PACKAGE |
| :--- | :---: | :--- |
| CD54HC02F3A | -55 to 125 | 14 Ld CERDIP |
| CD54HCT02F3A | -55 to 125 | 14 Ld CERDIP |
| CD74HC02E | -55 to 125 | 14 Ld PDIP |
| CD74HC02M | -55 to 125 | 14 Ld SOIC |
| CD74HC02MT | -55 to 125 | 14 Ld SOIC |
| CD74HC02M96 | -55 to 125 | 14 Ld SOIC |
| CD74HCT02E | -55 to 125 | 14 Ld PDIP |
| CD74HCT02M | -55 to 125 | 14 Ld SOIC |
| CD74HCT02MT | -55 to 125 | 14 Ld SOIC |
| CD74HCT02M96 | -55 to 125 | 14 Ld SOIC |

NOTE: When ordering, use the entire part number. The suffix 96 denotes tape and reel. The suffix T denotes a small-quantity reel of 250 .

## Pinout

| CD54HCO2, CD54HCT02 |
| :---: |
| (CERDIP) |

CD74C02, CD74HCT02
(PDIP, SOIC)
TOP VIEW

Functional Diagram


TRUTH TABLE

| INPUTS |  | OUTPUT |
| :---: | :---: | :---: |
| nA | nB | nY |
| L | L | H |
| L | H | L |
| H | L | L |
| H | H | L |

$\mathrm{H}=$ High Voltage Level, L = Low Voltage Level

## Logic Diagram



| Absolute Maximum Ratings |  |
| :---: | :---: |
| DC Supply Voltage, $\mathrm{V}_{\mathrm{CC}}$ | -0.5V to 7V |
| DC Input Diode Current, $\mathrm{I}_{1 / \mathrm{K}}$ |  |
| For $\mathrm{V}_{1}<-0.5 \mathrm{~V}$ or $\mathrm{V}_{1}>\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$ | $\pm 20 \mathrm{~mA}$ |
| DC Output Diode Current, IOK |  |
| For $\mathrm{V}_{\mathrm{O}}<-0.5 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{O}}>\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$ | $\pm 20 \mathrm{~mA}$ |
| DC Output Source or Sink Current per Output Pin, Io |  |
| For $\mathrm{V}_{\mathrm{O}}>-0.5 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{O}}<\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$ | $\pm 25 \mathrm{~mA}$ |
| DC $\mathrm{V}_{\mathrm{CC}}$ or Ground Current, $\mathrm{I}_{\text {CC or }} \mathrm{I}_{\mathrm{GND}}$ | $\pm 50 \mathrm{~mA}$ |

## Operating Conditions

Temperature Range ( $\mathrm{T}_{\mathrm{A}}$ ) . . . . . . . . . . . . . . . . . . . . . . $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ Supply Voltage Range, $\mathrm{V}_{\mathrm{CC}}$

```
    HC Types.
```


$\qquad$

Input Rise and Fall Time

| 4.5 |  | 1000ns (Max) |
| :---: | :---: | :---: |
|  |  | 500ns (Max) | 6 V $\qquad$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## NOTE:

1. The package thermal impedance is calculated in accordance with JESD 51-7.

## DC Electrical Specifications

| PARAMETER | SYMBOL | TEST CONDITIONS |  | $\begin{gathered} \mathrm{V}_{\mathrm{Cc}} \\ (\mathrm{~V}) \end{gathered}$ | $25^{\circ} \mathrm{C}$ |  |  | $-40^{\circ} \mathrm{C}$ TO $85{ }^{\circ} \mathrm{C}$ |  | $-55^{\circ} \mathrm{C}$ тO $125^{\circ} \mathrm{C}$ |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{1}(\mathrm{~V})$ | $10(\mathrm{~mA})$ |  | MIN | TYP | MAX | MIN | MAX | MIN | MAX |  |
| HC TYPES |  |  |  |  |  |  |  |  |  |  |  |  |
| High Level Input Voltage | $\mathrm{V}_{\mathrm{IH}}$ | - | - | 2 | 1.5 | - | - | 1.5 | - | 1.5 | - | V |
|  |  |  |  | 4.5 | 3.15 | - | - | 3.15 | - | 3.15 | - | V |
|  |  |  |  | 6 | 4.2 | - | - | 4.2 | - | 4.2 | - | V |
| Low Level Input Voltage | $\mathrm{V}_{\mathrm{IL}}$ | - | - | 2 | - | - | 0.5 | - | 0.5 | - | 0.5 | V |
|  |  |  |  | 4.5 | - | - | 1.35 | - | 1.35 | - | 1.35 | V |
|  |  |  |  | 6 | - | - | 1.8 | - | 1.8 | - | 1.8 | V |
| High Level Output Voltage CMOS Loads | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\mathrm{IL}}$ | -0.02 | 2 | 1.9 | - | - | 1.9 | - | 1.9 | - | V |
|  |  |  | -0.02 | 4.5 | 4.4 | - | - | 4.4 | - | 4.4 | - | V |
|  |  |  | -0.02 | 6 | 5.9 | - | - | 5.9 | - | 5.9 | - | V |
| High Level Output Voltage TTL Loads |  |  | - | - | - | - | - | - | - | - | - | V |
|  |  |  | -4 | 4.5 | 3.98 | - | - | 3.84 | - | 3.7 | - | V |
|  |  |  | -5.2 | 6 | 5.48 | - | - | 5.34 | - | 5.2 | - | V |
| Low Level Output Voltage CMOS Loads | VOL | $\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\mathrm{IL}}$ | 0.02 | 2 | - | - | 0.1 | - | 0.1 | - | 0.1 | V |
|  |  |  | 0.02 | 4.5 | - | - | 0.1 | - | 0.1 | - | 0.1 | V |
|  |  |  | 0.02 | 6 | - | - | 0.1 | - | 0.1 | - | 0.1 | V |
| Low Level Output Voltage TTL Loads |  |  | - | - | - | - | - | - | - | - | - | V |
|  |  |  | 4 | 4.5 | - | - | 0.26 | - | 0.33 | - | 0.4 | V |
|  |  |  | 5.2 | 6 | - | - | 0.26 | - | 0.33 | - | 0.4 | V |
| Input Leakage Current | 1 | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}} \text { or } \\ & \mathrm{GND} \end{aligned}$ | - | 6 | - | - | $\pm 0.1$ | - | $\pm 1$ | - | $\pm 1$ | $\mu \mathrm{A}$ |
| Quiescent Device Current | ICC | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}} \text { or } \\ & \mathrm{GND} \end{aligned}$ | 0 | 6 | - | - | 2 | - | 20 | - | 40 | $\mu \mathrm{A}$ |

DC Electrical Specifications (Continued)

| PARAMETER | SYMBOL | TEST CONDITIONS |  | $\mathrm{v}_{\mathrm{Cc}}$ <br> (V) | $25^{\circ} \mathrm{C}$ |  |  | $-40^{\circ} \mathrm{C}$ TO $85^{\circ} \mathrm{C}$ |  | $-55^{\circ} \mathrm{C}$ TO $125^{\circ} \mathrm{C}$ |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{1}(\mathrm{~V})$ | $10(\mathrm{~mA})$ |  | MIN | TYP | MAX | MIN | MAX | MIN | MAX |  |
| HCT TYPES |  |  |  |  |  |  |  |  |  |  |  |  |
| High Level Input Voltage | $\mathrm{V}_{\mathrm{IH}}$ | - | - | $\begin{gathered} 4.5 \text { to } \\ 5.5 \end{gathered}$ | 2 | - | - | 2 | - | 2 | - | V |
| Low Level Input Voltage | $\mathrm{V}_{\text {IL }}$ | - | - | $\begin{gathered} \hline 4.5 \text { to } \\ 5.5 \end{gathered}$ | - | - | 0.8 | - | 0.8 | - | 0.8 | V |
| High Level Output Voltage CMOS Loads | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\mathrm{IL}}$ | -0.02 | 4.5 | 4.4 | - | - | 4.4 | - | 4.4 | - | V |
| High Level Output Voltage TTL Loads |  |  | -4 | 4.5 | 3.98 | - | - | 3.84 | - | 3.7 | - | V |
| Low Level Output Voltage CMOS Loads | $\mathrm{V}_{\text {OL }}$ | $\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\mathrm{IL}}$ | 0.02 | 4.5 | - | - | 0.1 | - | 0.1 | - | 0.1 | V |
| Low Level Output Voltage TTL Loads |  |  | 4 | 4.5 | - | - | 0.26 | - | 0.33 | - | 0.4 | V |
| Input Leakage Current | 1 | $\begin{gathered} \hline \mathrm{V}_{\mathrm{CC}} \text { and } \\ \mathrm{GND} \end{gathered}$ | 0 | 5.5 | - |  | $\pm 0.1$ | - | $\pm 1$ | - | $\pm 1$ | $\mu \mathrm{A}$ |
| Quiescent Device Current | ${ }^{\text {cc }}$ | $\mathrm{V}_{\mathrm{CC}}$ or GND | 0 | 5.5 | - | - | 2 | - | 20 | - | 40 | $\mu \mathrm{A}$ |
| Additional Quiescent Device Current Per Input Pin: 1 Unit Load | $\Delta_{\mathrm{CC}}$ (Note 2) | $\begin{aligned} & \hline \mathrm{V}_{\mathrm{CC}} \\ & -2.1 \end{aligned}$ | - | $\begin{gathered} \hline 4.5 \text { to } \\ 5.5 \end{gathered}$ | - | 100 | 360 | - | 450 | - | 490 | $\mu \mathrm{A}$ |

NOTE:
2. For dual-supply systems theoretical worst case $\left(\mathrm{V}_{\mathrm{I}}=2.4 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC}}=5.5 \mathrm{~V}\right)$ specification is 1.8 mA .

## HCT Input Loading Table

| INPUT | UNIT LOADS |
| :---: | :---: |
| All | 1.5 |

NOTE: Unit Load is $\Delta \mathrm{I}_{\mathrm{CC}}$ limit specified in DC Electrical Table, e.g., $360 \mu \mathrm{~A}$ max at $25^{\circ} \mathrm{C}$.

Switching Specifications Input $t_{r}, t_{f}=6 n s$

| PARAMETER | SYMBOL | TEST CONDITIONS | $\mathrm{V}_{\mathrm{Cc}}(\mathrm{V})$ | $25^{\circ} \mathrm{C}$ |  |  | $\begin{gathered} -40^{\circ} \mathrm{C} \text { TO } \\ 85^{\circ} \mathrm{C} \end{gathered}$ |  | $\begin{gathered} -55^{\circ} \mathrm{C} \text { TO } \\ 125^{\circ} \mathrm{C} \end{gathered}$ |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | MIN | TYP | MAX | MIN | MAX | MIN | MAX |  |
| HC TYPES |  |  |  |  |  |  |  |  |  |  |  |
| Propagation Delay, Input to Output (Figure 1) | $\mathrm{t}_{\text {PLH, }} \mathrm{t}_{\text {PHL }}$ | $C_{L}=50 \mathrm{pF}$ | 2 | - | - | 90 | - | 115 | - | 135 | ns |
|  |  |  | 4.5 | - | - | 18 | - | 23 | - | 27 | ns |
|  |  |  | 6 | - | - | 15 | - | 20 | - | 23 | ns |
| Propagation Delay, Data Input to Output Y | $\mathrm{t}_{\text {PLH }}, \mathrm{t}_{\text {PHL }}$ | $C_{L}=15 \mathrm{pF}$ | 5 | - | 7 | - | - | - | - | - | ns |
| Transition Times (Figure 1) | ${ }_{\text {tLH }}, \mathrm{t}_{\text {THL }}$ | $C_{L}=50 \mathrm{pF}$ | 2 | - | - | 75 | - | 95 | - | 110 | ns |
|  |  |  | 4.5 | - | - | 15 | - | 19 | - | 22 | ns |
|  |  |  | 6 | - | - | 13 | - | 16 | - | 19 | ns |
| Input Capacitance | $\mathrm{C}_{\mathrm{IN}}$ | - | - | - | - | 10 | - | 10 | - | 10 | pF |

Switching Specifications Input $t_{r}, \mathrm{t}_{\mathrm{f}}=6$ ns (Continued)

| PARAMETER | SYMBOL | TEST CONDITIONS | $\mathrm{V}_{\mathrm{Cc}}$ (V) | $25^{\circ} \mathrm{C}$ |  |  | $\begin{gathered} -40^{\circ} \mathrm{C} \text { TO } \\ 85^{\circ} \mathrm{C} \end{gathered}$ |  | $\begin{gathered} -55^{\circ} \mathrm{C} \text { TO } \\ 125^{\circ} \mathrm{C} \end{gathered}$ |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | MIN | TYP | MAX | MIN | MAX | MIN | MAX |  |
| Power Dissipation Capacitance (Notes 3, 4) | CPD | - | 5 | - | 26 | - | - | - | - | - | pF |
| HCT TYPES |  |  |  |  |  |  |  |  |  |  |  |
| Propagation Delay, Input to Output (Figure 2) | ${ }_{\text {t }}{ }^{\text {LH, }}$ tPHL | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$ | 4.5 | - | - | 21 | - | 26 | - | 32 | ns |
| Propagation Delay, Data Input to Output Y | ${ }_{\text {tPLH, }}$ tPHL | $C_{L}=15 \mathrm{pF}$ | 5 | - | 8 | - | - | - | - | - | ns |
| Transition Times (Figure 2) | ${ }_{\text {t }}$ LH, $\mathrm{t}_{\text {THL }}$ | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$ | 4.5 | - | - | 15 | - | 19 | - | 22 | ns |
| Input Capacitance | $\mathrm{C}_{\text {IN }}$ | - | - | - | - | 10 | - | 10 | - | 10 | pF |
| Power Dissipation Capacitance (Notes 3, 4) | CPD | - | 5 | - | 26 | - | - | - | - | - | pF |

NOTES:
3. $C_{P D}$ is used to determine the dynamic power consumption, per gate.
4. $P_{D}=V_{C C}{ }^{2} f_{i}\left(C_{P D}+C_{L}\right)$ where $f_{i}=$ input frequency, $C_{L}=$ output load capacitance, $V_{C C}=$ supply voltage.

## Test Circuits and Waveforms



FIGURE 1. HC AND HCU TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC


FIGURE 2. HCT TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

## PACKAGING INFORMATION

| Orderable Device | Status ${ }^{(1)}$ | Package Type | Package Drawing | Pins | Package Qty | $\text { Eco Plan }{ }^{(2)}$ | Lead/Ball Finish | MSL Peak Temp ${ }^{(3)}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 5962-8975101CA | ACTIVE | CDIP | $J$ | 14 | 1 | TBD | A42 | N / A for Pkg Type |
| CD54HC02F | ACTIVE | CDIP | J | 14 | 1 | TBD | A42 | N / A for Pkg Type |
| CD54HC02F3A | ACTIVE | CDIP | J | 14 | 1 | TBD | A42 | N/ A for Pkg Type |
| CD54HCT02F | ACTIVE | CDIP | J | 14 | 1 | TBD | A42 | N/ A for Pkg Type |
| CD54HCT02F3A | ACTIVE | CDIP | J | 14 | 1 | TBD | A42 | N/ A for Pkg Type |
| CD74HC02E | ACTIVE | PDIP | N | 14 | 25 | Pb-Free <br> (RoHS) | CU NIPDAU | N / A for Pkg Type |
| CD74HC02EE4 | ACTIVE | PDIP | N | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| CD74HC02M | ACTIVE | SOIC | D | 14 | 50 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HC02M96 | ACTIVE | SOIC | D | 14 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HC02M96E4 | ACTIVE | SOIC | D | 14 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HC02M96G4 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HC02ME4 | ACTIVE | SOIC | D | 14 | 50 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HC02MG4 | ACTIVE | SOIC | D | 14 | 50 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HC02MT | ACTIVE | SOIC | D | 14 | 250 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HC02MTE4 | ACTIVE | SOIC | D | 14 | 250 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HC02MTG4 | ACTIVE | SOIC | D | 14 | 250 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HCT02E | ACTIVE | PDIP | N | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N/A for Pkg Type |
| CD74HCT02EE4 | ACTIVE | PDIP | N | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N/ A for Pkg Type |
| CD74HCT02M | ACTIVE | SOIC | D | 14 | 50 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HCT02M96 | ACTIVE | SOIC | D | 14 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HCT02M96E4 | ACTIVE | SOIC | D | 14 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HCT02M96G4 | ACTIVE | SOIC | D | 14 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no Sb/Br) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HCT02ME4 | ACTIVE | SOIC | D | 14 | 50 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no Sb/Br) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HCT02MG4 | ACTIVE | SOIC | D | 14 | 50 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no Sb/Br) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HCT02MT | ACTIVE | SOIC | D | 14 | 250 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HCT02MTE4 | ACTIVE | SOIC | D | 14 | 250 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no Sb/Br) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| CD74HCT02MTG4 | ACTIVE | SOIC | D | 14 | 250 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS \& no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The $\mathrm{Pb}-\mathrm{Free} / \mathrm{Green}$ conversion plan has not been defined.
Pb -Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb -Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS \& no $\mathbf{S b} / \mathbf{B r}$ ): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine ( Br ) and Antimony (Sb) based flame retardants ( Br or Sb do not exceed $0.1 \%$ by weight in homogeneous material)
${ }^{(3)}$ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## TAPE AND REEL INFORMATION



| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel <br> Width <br> W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | $\begin{gathered} \mathrm{P} 1 \\ (\mathrm{~mm}) \end{gathered}$ | $\begin{gathered} \text { W } \\ (\mathrm{mm}) \end{gathered}$ | Pin1 Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CD74HC02M96 | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| CD74HCT02M96 | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CD74HC02M96 | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |
| CD74HCT02M96 | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |



| DIM PINS ** | 14 | 16 | 18 | 20 |
| :---: | :---: | :---: | :---: | :---: |
| A | 0.300 <br> $(7,62)$ <br> BSC | 0.300 <br> $(7,62)$ <br> BSC | 0.300 <br> $(7,62)$ <br> BSC | 0.300 <br> $(7,62)$ <br> BSC |
| B MAX | 0.785 <br> $(19,94)$ | .840 <br> $(21,34)$ | 0.960 <br> $(24,38)$ | 1.060 <br> $(26,92)$ |
| B MIN | - | - | - | - |
| C MAX | 0.300 <br> $(7,62)$ | 0.300 <br> $(7,62)$ | 0.310 <br> $(7,87)$ | 0.300 <br> $(7,62)$ |
| C MIN | 0.245 <br> $(6,22)$ | 0.245 <br> $(6,22)$ | 0.220 <br> $(5,59)$ | 0.245 <br> $(6,22)$ |



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package is hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

D (R-PDSO-G14) PLASTIC SMALL-OUTLINE PACKAGE


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.

C Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed $.006(0,15)$ per end.
D Body width does not include interlead flash. Interlead flash shall not exceed $.017(0,43)$ per side.
E. Reference JEDEC MS-012 variation AB.

N (R-PDIP-T**)
PLASTIC DUAL-IN-LINE PACKAGE
16 PINS SHOWN


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C) Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).

D The 20 pin end lead shoulder width is a vendor option, either half or full width.

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